



International Conference on Scanning Probe Microscopy on Soft and Polymeric Materials

23-26 September 2012, Rolduc Abbey, Kerkrade, The Netherlands

<http://www.spm-p.org/>

- Call for Papers -

Dear Colleagues,

Herewith we invite submissions for oral and poster contributions for presentation at the **International Conference on Scanning Probe Microscopy on Soft and Polymeric Materials 2012 (SPM on SPM 2012)**, which will take place in Rolduc Abbey, Kerkrade, The Netherlands, between September 23-26, 2012.

SPM on SPM 2012 is a unique conference covering the full range of scanning probe microscopy on soft matter, polymeric materials, as well as biological systems.

The conference offers a great opportunity to share your research with worldwide leading scientists active in this field, as well as with industrial colleagues. A short course, invited lectures and a company exhibit are part of the conference program.

For further information please visit the conference website at: <http://www.spm-p.org/>

The session topics include:

- AFM in polymers, biology and life science / bioinspired materials; Molecular imaging; Force spectroscopy; Quantitative surface mechanics; (Nano)indentation; Tribology; Adhesion; Surface properties of thin films; Advanced and novel AFM methods; Surface chemical spectroscopy; Functional polymeric materials; Electrical measurements; Combined / hyphenated techniques; AFM in industries; Theory of AFM for soft materials; Perspectives and future development of AFM; etc.

Deadlines:

Abstract submission: 1 May 2012

Notification of Acceptance: 1 June 2012

Registration and Payment: 15 June 2012

Papers will be selected by the scientific committee based on scientific merit of the submitted abstracts .

We cordially invite you to submit your contribution (oral or poster) at:

<http://www.spm-p.org/abstract-submission.aspx>

We look forward to seeing you in Rolduc in September 2012.

Please inform colleagues and coworkers about this exciting meeting !

The Organizing Committee

Philippe Leclère, Peter Schön, Holger Schönherr, G. Julius Vancso, Georg Bar and Anton-Jan Bons